

Lonten P-channel -30V, -6.5A, 46mΩ Power MOSFET

Description

These P-Channel enhancement mode power field effect transistors are using trench DMOS technology. This advanced technology has been especially tailored to minimize on-state resistance, provide superior switching performance, and with stand high energy pulse in the avalanche and commutation mode. These devices are well suited for high efficiency fast switching applications.

Features

- \bullet -30V,-6.5A,R_{DS(ON).max}=46m Ω @V_{GS}=-10V
- Improved dv/dt capability
- Fast switching
- Green device available

Applications

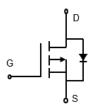
- PWM applications
- Load switch
- Portable Equipment

Product Summary

 $\begin{array}{lll} V_{DSS} & -30V \\ R_{DS(on).max} \textcircled{0} \ V_{GS} \text{=-} 10V & 46m\Omega \\ I_D & -6.5A \end{array}$

Pin Configuration





30F-0

P-Channel MOSFET



Absolute Maximum Ratings T_A = 25°C unless otherwise noted

Parameter	Symbol	Value	Unit
Drain-Source Voltage	$V_{ t DSS}$	-30	V
Continuous drain current (T _A = 25°C)		-6.5	А
Continuous drain current (T _A = 100°C)	I _D	-4.1	A
Pulsed drain current ¹⁾	I _{DM}	-26	А
Gate-Source voltage	V_{GSS}	±20	V
Power Dissipation (T _A = 25°C)	P _D	2.9	W
Storage Temperature Range	T _{STG}	-55 to +150	°C
Operating Junction Temperature Range	T_J	-55 to +150	°C

Thermal Characteristics

Parameter	Symbol	Value	Unit
Thermal Resistance, Junction-to-Ambient	$R_{\theta JA}$	43	°C/W



Package Marking and Ordering Information

Device	Device Package	Marking
LPL4459	SOP-8	LPL4459

Electrical Characteristics T_J = 25°C unless otherwise noted

Parameter	Symbol	Test Condition	Min.	Тур.	Max.	Unit
Static characteristics				ı		ı
Drain-source breakdown voltage	BV _{DSS}	V _{GS} =0 V, I _D =-250uA	-30			V
Gate threshold voltage	$V_{GS(th)}$	V _{DS} =V _{GS} , I _D =-250uA	-1.2	-1.7	-2.2	V
Drain-source leakage current		V _{DS} =-30 V, V _{GS} =0 V, T _J = 25°C			-1	μA
	I _{DSS}	V _{DS} =-24V, V _{GS} =0 V, T _J = 125°C			-10	μA
Gate leakage current, Forward	I _{GSSF}	V _{GS} =20 V, V _{DS} =0 V			100	nA
Gate leakage current, Reverse	I _{GSSR}	V _{GS} =-20 V, V _{DS} =0 V			-100	nA
	Ъ	V _{GS} =-10 V, I _D =-6.5 A		33	46	mΩ
Drain-source on-state resistance	R _{DS(on)}	V _{GS} =-4.5 V, I _D =-5A		43	72	mΩ
Forward transconductance	g fs	$V_{DS} = -5 \text{ V}$, $I_{D} = -6.5 \text{A}$		17		S
Dynamic characteristics	·			•		
Input capacitance	C _{iss}			940		
Output capacitance	Coss	$V_{DS} = -15 \text{ V}, V_{GS} = 0 \text{ V},$ $F = 1 \text{MHz}$		103		pF
Reverse transfer capacitance	C _{rss}	- 1' = 11VII 12		88		1
Turn-on delay time	t _{d(on)}			3.9		
Rise time	t _r	V _{DD} =-15V,V _{GS} =-10V,I _D =-6.5A,		33.2		ns
Turn-off delay time	$t_{d(off)}$	Rg=3Ω		39.3		
Fall time	t _f			9.2		
Gate resistance	R_g	V _{GS} =0V,V _{DS} =0V,f=1MHz		11		Ω
Gate charge characteristics	<u> </u>					
Gate to source charge	Q_{gs}			2.44		
Gate to drain charge	Q_{gd}	V _{DS} =-15 V, I _D =-6.5A,		2.92		nC
Gate charge total	Q_g	- V _{GS} =-10 V		14.6		
Drain-Source diode characteris	tics and Maxi	mum Ratings		•		•
Continuous Source Current	Is				-6.5	А
Pulsed Source Current ²⁾	I _{SM}]			-26	Α
Diode Forward Voltage	V_{SD}	V _{GS} =0V, I _S =-1A, T _J =25℃			-1.2	V

Notes:

Version 1.2, May- 2019 2 www.lonten.cc

^{1:} Repetitive Rating: Pulse width limited by maximum junction temperature.

^{2:} Pulse Test: Pulse Width $\leq 300 \,\mu\,\text{s}$, Duty Cycle $\leq 2\%$.



30

25

20

15

10

5

0

-I_n-Drain current (A)

Electrical Characteristics Diagrams

Figure 1. Typ. Output Characteristics

V_{ss}=-4.5V,-5V,-6V,-7V,-8V,-9V,-10V

From Bottom to Tep

Common Source

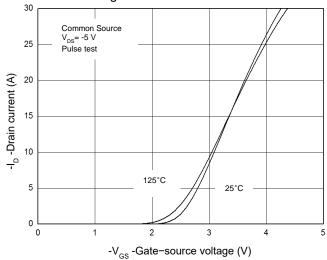
T_A = 25°C

Pulse test

V_{GS}=-3V

V_{GS}=-2.5V

Figure 2. Transfer Characteristics





-V_{DS} -Drain-source voltage (V)

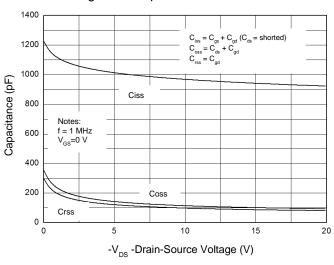


Figure 4. Gate Charge Waveform

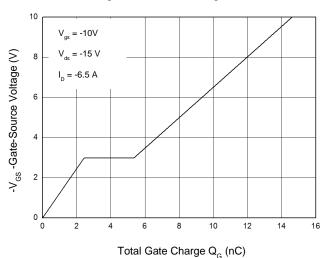


Figure 5. Body-Diode Characteristics

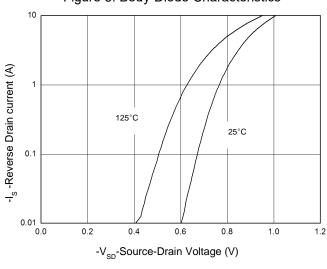
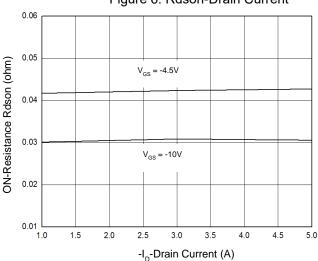


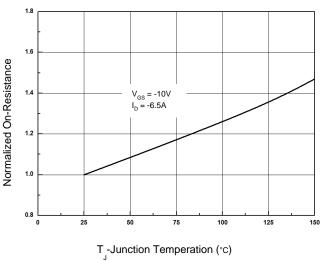
Figure 6. Rdson-Drain Current

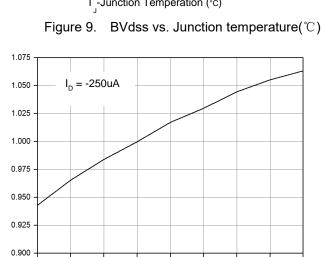




Normalized Drain to Source Voltage

Figure 7. Rdson-Junction Temperature(℃)





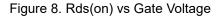
T_J-Junction Temperation (°c)

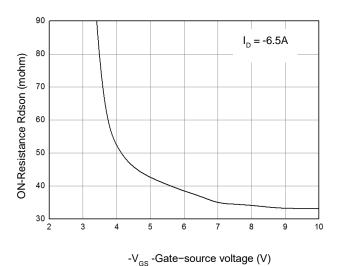
100

125

150

-25





40.14

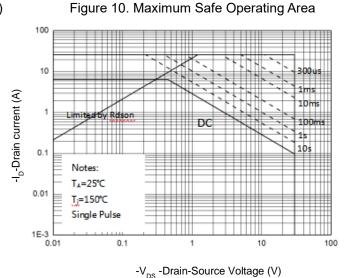
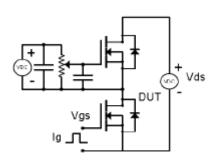


Figure 11. Normalized Maximum Transient Thermal Impedance (RthJA) 10 D=Ton/T In descending oder Normalized Transient Bush Thermal Resistance D=0.5, 0.3, 0.1, 0.05, 0.02, 0.01, single pulse $T_{J,PK} = T_C + P_{DM} \cdot Z_{\theta JC} \cdot R_{\theta JC}$ 1 R_{OJA}=43°C/W 0.1 Single Pulse 0.01 1E-5 1E-3 100 1000 1E-4 0.01 0.1 1 10 Pulse Width t (s)



Test Circuit & Waveform

Figure 8. Gate Charge Test Circuit & Waveform



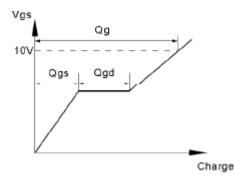
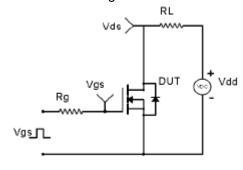


Figure 9. Resistive Switching Test Circuit & Waveforms



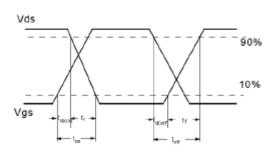
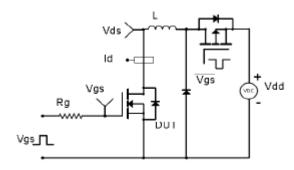


Figure 10. Unclamped Inductive Switching (UIS) Test Circuit & Waveform



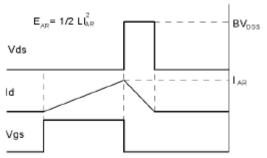
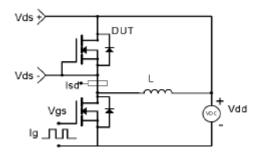
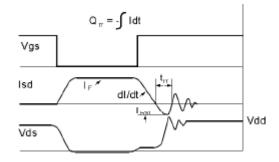


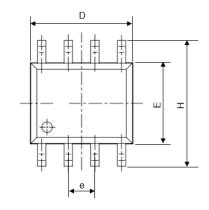
Figure 11. Diode Recovery Circuit & Waveform

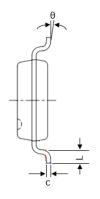


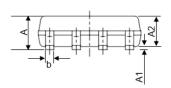




Mechanical Dimensions for SOP-8

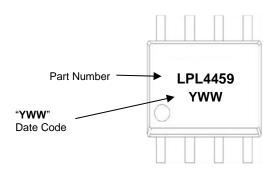






COMMON DIMENSIONS					
SYMBOL	MILLIMETERS		INCHS		
STIVIBUL	MIN	MAX	MIN	MAX	
Α	1.45	1.75	0.057	0.069	
A1	0.05	0.25	0.002	0.010	
A2	1.35	1.55	0.053	0.061	
b	0.35	0.45	0.014	0.018	
С	0.19	0.27	0.007	0.011	
D	4.80	5.00	0.189	0.197	
Е	3.78	3.98	0.149	0.157	
е	1.27 TYP.		0.050 TYP.		
Н	5.80	6.20	0.228	0.244	
L	0.40	1.00	0.016	0.039	
θ	0°	8°	0°	8°	

SOP-8 Part Marking Information





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